

Notice of References Cited	Application/Control No. 10/530,436		Applicant(s)/Patent Under Reexamination SHEN ET AL.	
	Examiner HEE SOO KIM		Art Unit 2457	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0143972 A1	10-2002	Christopoulos et al.	709/231
*	B	US-2003/0156108 A1	08-2003	Vetro, Anthony	345/418
	C	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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